Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/839,137	AKASHI, AKIRA
Examiner	Art Unit ,

2621

Patrick L. Edwards

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Class	Subclass	Date	Examiner
382	100, 232	as January	#
348 UJO	231.3 231.5 231.6	2005	#
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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